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(71) Applicant (for all designated States except US): **LAM RESEARCH CORPORATION** [US/US]; 4650 Cushing Parkway, Fremont, CA 94538-6470 (US).

(72) Inventors; and

(75) Inventors/Applicants (for US only): **SHIH, Hong** [US/US]; 19048 Garnet Way, Walnut, CA 91789 (US). **CHEN, Anthony, L.** [US/US]; 3771 Grillo Court, Pleasanton, CA 94566 (US). **TAN, Sok, Kiow** [US/US]; 1892 Firebrick Terrace, Union City, CA 94587 (US). **HWANG, Stephen** [US/US]; 2000 Walnut Avenue, #D302, Fremont, CA 94538 (US). **DAUGHERTY, John** [US/US]; 36220 Birkshire Place, Newark, CA 94560 (US). **MOREL, Bruno** [US/US]; 640 Park Court, Santa Clara, CA 95050 (US).

(74) Agent: **NGUYEN, Joseph, A.**; IPSG, P.C., P.O. Box 700640, San Jose, CA 95170-0640 (US).

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(54) Title: METHODS FOR CLEANING A SET OF STRUCTURES COMPRISING YTTRIUM OXIDE IN A PLASMA PROCESSING SYSTEM

(57) Abstract: A method of removing a set of particles from a set of structures including yttrium oxide is disclosed. The method includes exposing the set of structures to a first solution including an oxidizer for a first period. The method also includes removing the set of structures from the first solution, and exposing the set of structures to a second solution including a keytone reagent for a second period. The method further includes removing the set of structures from the second solution, and mechanically rubbing the set of structures with a third solution including a first set of acids for a third period.



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